


<b>Search Notes</b>  	<b>Application/Control No.</b>  09847590	<b>Applicant(s)/Patent Under Reexamination</b>  BURKHART, REED
	<b>Examiner</b>  SARGON N NANO	<b>Art Unit</b>  2457

SEARCHED			
Class	Subclass	Date	Examiner
709	203,217,219,224,225,227,228	3/25/2009	SN
705	26,27,37,39,64,75	3/25/2009	SN

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	3/24/2009	SN
NPL search	3/24/2009	SN
Consulted with Tod Swan for 101 issues	3/23/2009	SN
Consulted with Primary A. Salad	3/23/2009	SN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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